## Applicant(s)/Patent Under Application/Control No. Reexamination 10/643,078 NAKAZAWA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2617 David Q. Nguyen **U.S. PATENT DOCUMENTS** Date Document Number Classification Name MM-YYYY Country Code-Number-Kind Code US-6,646,449 11-2003 Seppinen et al. 324/624 Α В US-6,292,519 09-2001 Popovic, Branislav M. 375/346 US-6,885,694 04-2005 He et al. 375/144 С 02-2005 D US-2005/0032472 Jiang et al. 455/013.4 US-Ε US-F US-G Н US-US-1 US-

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